


<b>Search Notes</b> 	<b>Application/Control No.</b> 10540658	<b>Applicant(s)/Patent Under Reexamination</b> MATHIES ET AL.
	<b>Examiner</b> Young J Kim	<b>Art Unit</b> 1637

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

<b>SEARCH NOTES</b>		
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Patent Databases (USPT, USPGP, EPO, JPO, DERWENT, IBM-TDB)	2/8/2008	/YJK/
see enclosed for text-search strategies	2/8/2008	/YJK/

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>